

**Search Notes**

Application/Control No.

09/382,375

Examiner

Hai V. Nguyen

Applicant(s)/Patent under  
Reexamination

PHILYAW ET AL.

Art Unit

2142

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
717	174	8/15/2006	HN
715	501.1	8/15/2006	HN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consult with Thong Vu (AU 2142): allowability	8/15/2006	HN
Interference Search (see Search history printout report)	8/15/2006	HN